

CMOS Multifunction Expandable 8-Input Gate

High-Voltage Types (20-Volt Rating)

CD4048B is an 8-input gate having four control inputs. Three binary control inputs — K_a , K_b , and K_c — provide the implementation of eight different logic functions. These functions are OR, NOR, AND, NAND, OR/AND, OR/NAND, AND/OR and AND/NOR.

A fourth control input, K_d , provides the user with a 3-state output. When control input K_d is high, the output is either a logic 1 or a logic 0 depending on the inner states. When control input K_d is low, the output is an open circuit. This feature enables the user to connect this device to a common bus line.

MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE RANGE, (V_{DD})

Voltages referenced to V_{SS} Terminal -0.5V to +20V

INPUT VOLTAGE RANGE, ALL INPUTS -0.5V to V_{DD} +0.5V

DC INPUT CURRENT, ANY ONE INPUT $\pm 10\text{mA}$

POWER DISSIPATION PER PACKAGE (P_D):

For $T_A = -55^\circ\text{C}$ to $+100^\circ\text{C}$ 500mW

For $T_A = +100^\circ\text{C}$ to $+125^\circ\text{C}$ Derate Linearity at $12\text{mW}/^\circ\text{C}$ to 200mW

DEVICE DISSIPATION PER OUTPUT TRANSISTOR

For $T_A = \text{FULL PACKAGE-TEMPERATURE RANGE (All Package Types)}$ 100mW

OPERATING-TEMPERATURE RANGE (T_A) -55°C to $+125^\circ\text{C}$

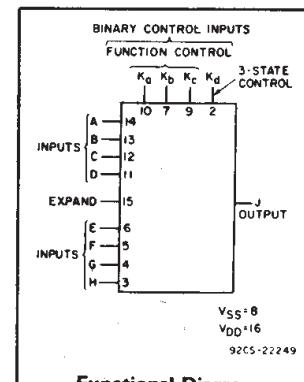
STORAGE TEMPERATURE RANGE ($T_{S\text{ig}}$) -65°C to $+150^\circ\text{C}$

LEAD TEMPERATURE (DURING SOLDERING):

At distance $1/16 \pm 1/32$ inch ($1.59 \pm 0.79\text{mm}$) from case for 10s max $+265^\circ\text{C}$

In addition to the eight input lines, an EXPAND input is provided that permits the user to increase the number of inputs into a CD4048B (see Fig. 2). For example, two CD4048Bs can be cascaded to provide a 16-input multifunction gate. When the EXPAND input is not used, it should be connected to V_{SS} .

The CD4048B-series types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (M, M96, MT, and NSR suffixes), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).



Functional Diagram

Features:

- Three-state output
- Many logic functions available in one package
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of $1\ \mu\text{A}$ at $18\ \text{V}$ (full package-temperature range), $100\ \text{nA}$ at $18\ \text{V}$ and 25°C
- Noise margin (full package-temperature range) = 1 V at $V_{DD}=5\ \text{V}$, 2 V at $V_{DD}=10\ \text{V}$, 2.5 V at $V_{DD}=15\ \text{V}$
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

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COMMERCIAL CMOS
HIGH VOLTAGE ICs

Applications:

- Selection of up to 8 logic functions
- Digital control of logic
- General-purpose gating logic
 - Decoding
 - Encoding

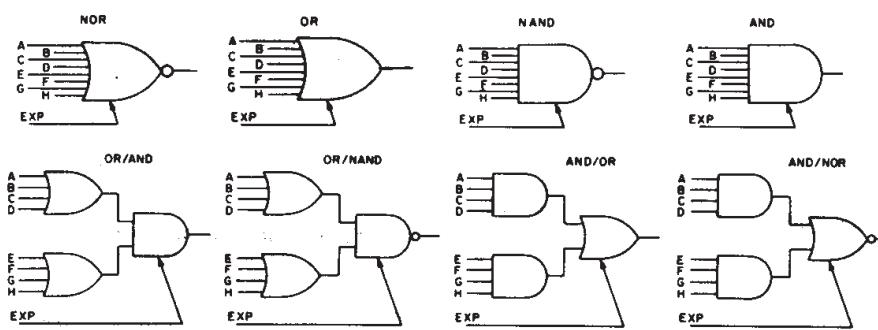
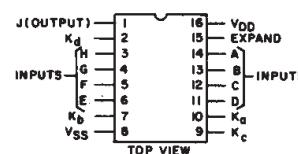


Fig. 1 – Basic logic configurations.

RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	LIMITS		UNITS
	MIN.	MAX.	
Supply-Voltage Range (For $T_A = \text{Full Package Temperature Range}$)	3	18	V



TOP VIEW
92CS-20246RI

TERMINAL ASSIGNMENT

CD4048B Types

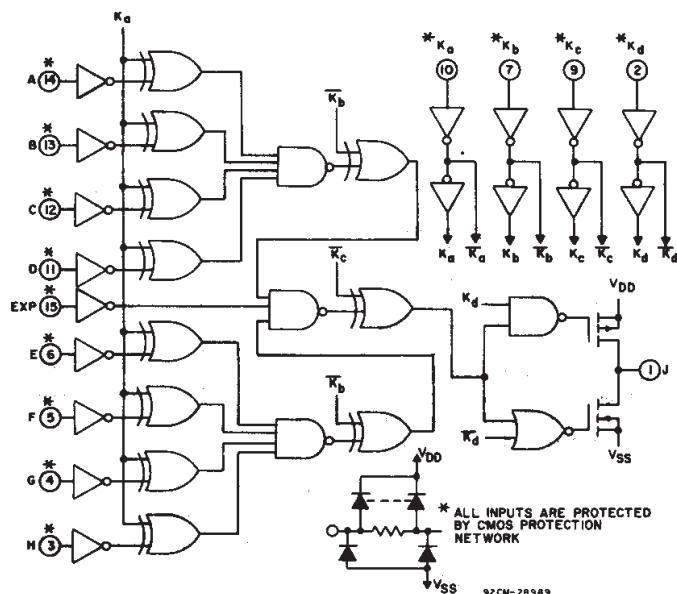


Fig. 2 – Logic diagram.

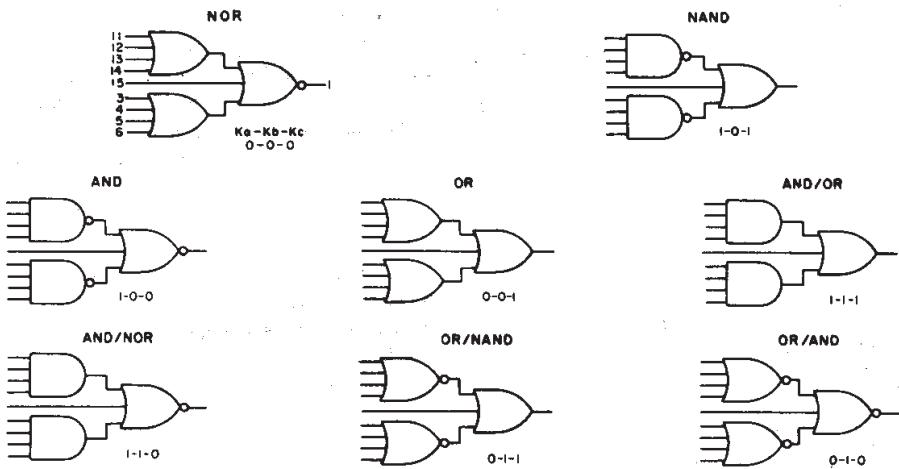


Fig. 3 – Actual-circuit logic configurations.

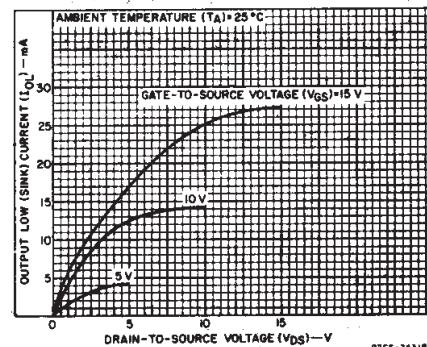
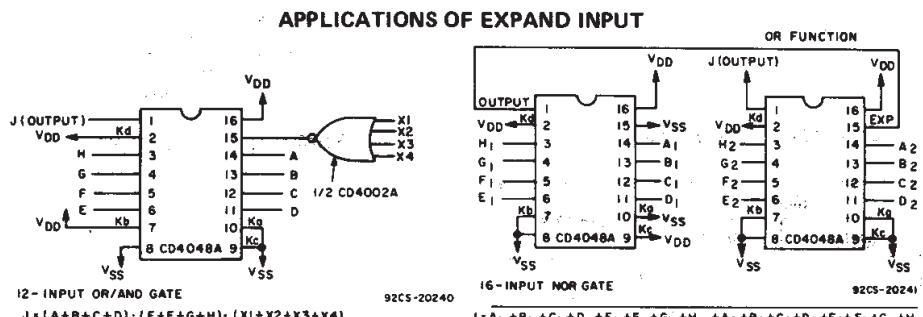


Fig. 6 – Typical output low (sink) current characteristics.

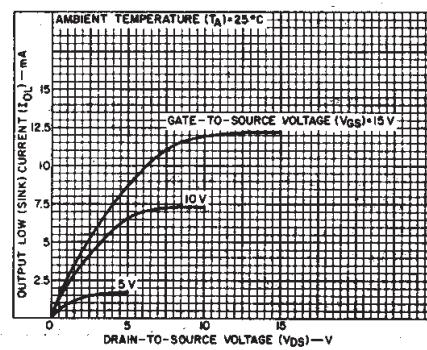


Fig. 7 – Minimum output low (sink) current characteristics.

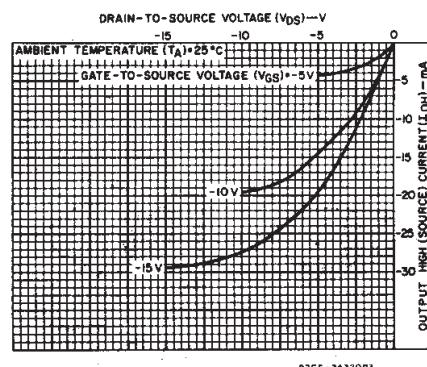


Fig. 8 – Typical output high (source) current characteristics.

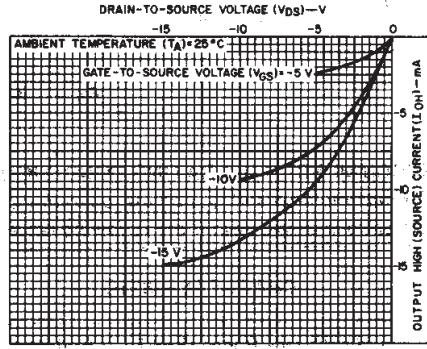


Fig. 9 – Minimum output high (source) current characteristics.

CD4048B Types

STATIC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	CONDITIONS			LIMITS AT INDICATED TEMPERATURES (°C)						UNITS	
				+25							
	V _O (V)	V _{IN} (V)	V _{DD} (V)	-55	-40	+85	+125	Min.	Typ.	Max.	
Quiescent Device Current, I _{DD} Max.	—	0,5	5	0,25	0,25	7,5	7,5	—	0,01	0,25	μA
	—	0,10	10	0,5	0,5	15	15	—	0,01	0,5	
	—	0,15	15	1	1	30	30	—	0,01	1	
	—	0,20	20	5	5	150	150	—	0,02	5	
Output Low (Sink) Current I _{OL} Min.	0,4	0,5	5	0,64	0,61	0,42	0,36	0,51	1	—	mA
	0,5	0,10	10	1,6	1,5	1,1	0,9	1,3	2,6	—	
	1,5	0,15	15	4,2	4	2,8	2,4	3,4	6,8	—	
Output High (Source) Current, I _{OH} Min.	4,6	0,5	5	-0,64	-0,61	-0,42	-0,36	-0,51	-1	—	mA
	2,5	0,5	5	-2	-1,8	-1,3	-1,15	-1,6	-3,2	—	
	9,5	0,10	10	-1,6	-1,5	-1,1	-0,9	-1,3	-2,6	—	
	13,5	0,15	15	-4,2	-4	-2,8	-2,4	-3,4	-6,8	—	
Output Voltage: Low-Level, V _{OL} Max.	—	0,5	5	0,05			—	0	0,05	V	
	—	0,10	10	0,05			—	0	0,05		
	—	0,15	15	0,05			—	0	0,05		
Output Voltage: High-Level, V _{OH} Min.	—	0,5	5	4,95			4,95	5	—	V	
	—	0,10	10	9,95			9,95	10	—		
	—	0,15	15	14,95			14,95	15	—		
Input Low Voltage, V _{IL} Max.	0,5,4,5	—	5	1,5			—	—	1,5	V	
	1,9	—	10	3			—	—	3		
	1,5,13,5	—	15	4			—	—	4		
Input High Voltage, V _{IH} Min.	0,5,4,5	—	5	3,5			3,5	—	—	V	
	1,9	—	10	7			7	—	—		
	1,5,13,5	—	15	11			11	—	—		
Input Current I _{IN} Max.		0,18	18	±0,1	±0,1	±1	±1	—	±10 ⁻⁵	±0,1	μA
3-State Output Current, I _{OUT}	0,18	0,18	18	±0,4	±0,4	±12	±12	—	±10 ⁻⁴	±0,4	μA

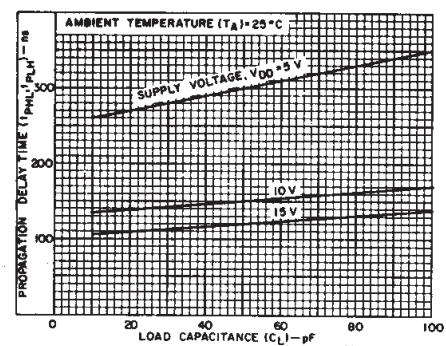


Fig. 10 – Typical propagation delay time (logic inputs to output) as a function of load capacitance.

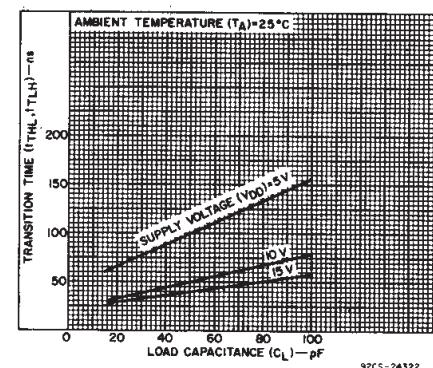


Fig. 11 – Typical transition time vs. load capacitance.

IMPLEMENTATION OF EXPAND INPUT FOR 9 OR MORE INPUTS

OUTPUT FUNCTION	FUNCTION NEEDED AT EXPAND INPUT	OUTPUT BOOLEAN EXPRESSION
NOR	OR	$J = \overline{(A+B+C+D+E+F+G+H)} + (\text{EXP})$
OR	OR	$J = (A+B+C+D+E+F+G+H) + (\text{EXP})$
AND	NAND	$J = \overline{(ABCDEFHG)} \cdot \overline{(\text{EXP})}$
NAND	NAND	$J = \overline{\overline{(ABCDEFHG)}} \cdot \overline{(\text{EXP})}$
OR/AND	NOR	$J = \overline{(A+B+C+D)} \cdot \overline{(E+F+G+H)} \cdot \overline{(\text{EXP})}$
OR/NAND	NOR	$J = \overline{(A+B+C+D)} \cdot \overline{(E+F+G+H)} \cdot \overline{(\text{EXP})}$
AND/NOR	AND	$J = \overline{(ABCD)} + \overline{(EFGH)} + (\text{EXP})$
AND/OR	AND	$J = \overline{(ABCD)} + \overline{(EFGH)} + (\text{EXP})$

Note: (EXP) designates the EXPAND function (i.e., $X_1+X_2+\dots+X_N$).

NOTE:
Refer to FUNCTION TRUTH TABLE for connection of unused inputs.

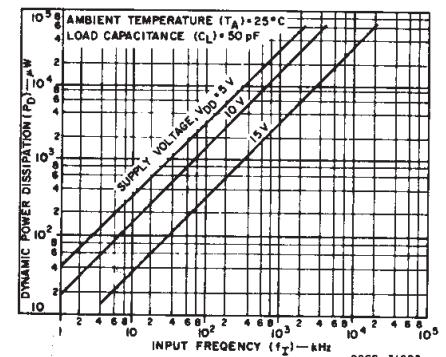


Fig. 12 – Typical power dissipation as a function of input frequency.

CD4048B Types

DYNAMIC CHARACTERISTICS at $T_A=25^\circ\text{C}$, $C_L=50 \mu\text{F}$, Input $t_r, t_f=20 \text{ ns}$,
 $R_L=200 \text{ k}\Omega$ unless otherwise specified

CHARACTERISTIC	TEST CONDITIONS	LIMITS		UNITS
		V _{DD} V	All Package Types Typ. Max.	
Propagation Delay: t_{PHL}, t_{PLH} Inputs to Output and K _a to Output		5 10 15	300 150 120	ns
K _b to Output		5 10 15	225 85 55	ns
K _c to Output		5 10 15	140 50 40	ns
Expand Input to Output		5 10 15	190 90 65	ns
3-State Propagation Delay: K _d to Output t_{PHZ}, t_{PLZ} t_{PZH}, t_{PZL}	$R_L=1 \text{ k}\Omega$ See Fig. 21	5 10 15	80 35 25	ns
Transition Time: t_{THL}, t_{TLH}		5 10 15	100 50 40	ns
Input Capacitance: C _I	Any Input		5	7
3-State Output Capacitance			5	10

FUNCTION TRUTH TABLE

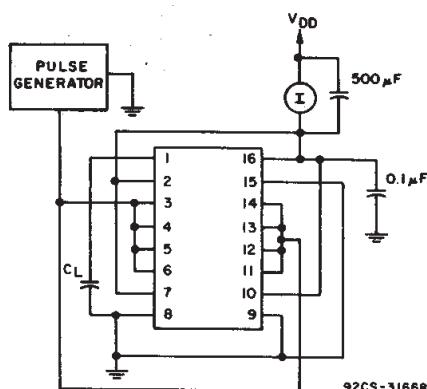


Fig. 13 – Dynamic power dissipation test circuit.

OUTPUT FUNCTION	BOOLEAN EXPRESSION	K _a	K _b	K _c	UNUSED INPUT*
NOR	$J=A+B+C+D+E+F+G+H$	0	0	0	V _{SS}
OR	$J=A+B+C+D+E+F+G+H$	0	0	1	V _{SS}
OR/AND	$J=(A+B+C+D) \cdot (E+F+G+H)$	0	1	0	V _{SS}
OR/NAND	$J=(A+B+C+D) \cdot (E+F+G+H)$	0	1	1	V _{SS}
AND	$J=ABCDEF GH$	1	0	0	V _{DD}
NAND	$J=ABCDEF GH$	1	0	1	V _{DD}
AND/NOR	$J=\overline{ABCD} + EFGH$	1	1	0	V _{DD}
AND/OR	$J=ABCD + EFGH$	1	1	1	V _{DD}

K_d=1 Normal Inverter Action

K_d=0 High Impedance Output

EXPAND Input=0

* See Figs. 1,2,3,4, and 5.

TEST CIRCUITS - STATIC MEASUREMENTS

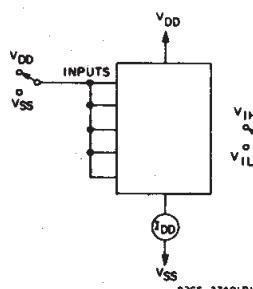


Fig. 14 – Quiescent device current test circuit.

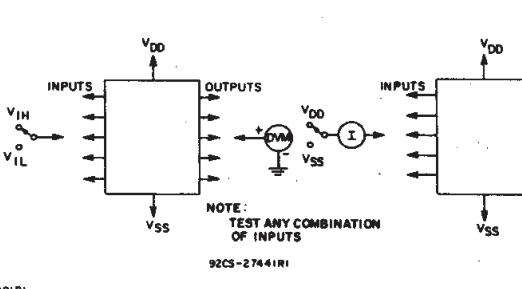


Fig. 15 – Input voltage test circuit.

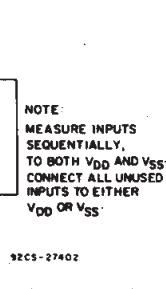


Fig. 16 – Input current test circuit.

CD4048B Types

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COMMERCIAL CMOS
HIGH VOLTAGE ICs

TEST CIRCUITS - DYNAMIC MEASUREMENTS

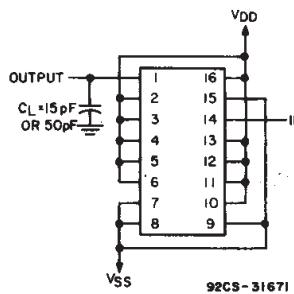


Fig. 17 – Test circuit for t_{PHL} ,
 t_{THL} , and t_{TLH} (AND)
measurements.

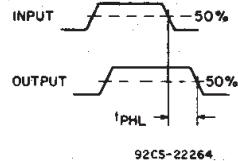


Fig. 18 – Waveforms for t_{PHL}
and t_{PZH} (AND).

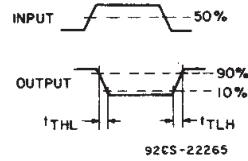


Fig. 19 – Waveforms for t_{THL}
and t_{TLH} (AND).

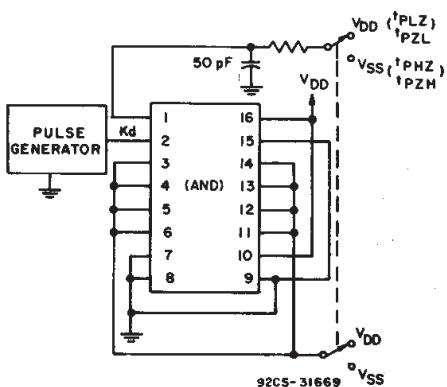


Fig. 20 – Test circuit for t_{PZL} , t_{PZH} , t_{PLZ} ,
and t_{PHZ} (AND).

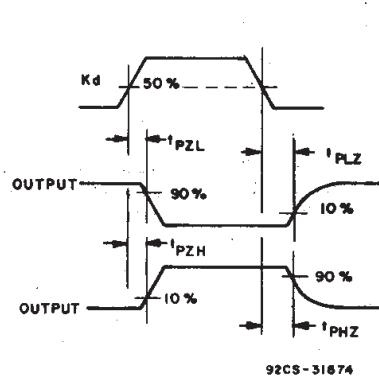
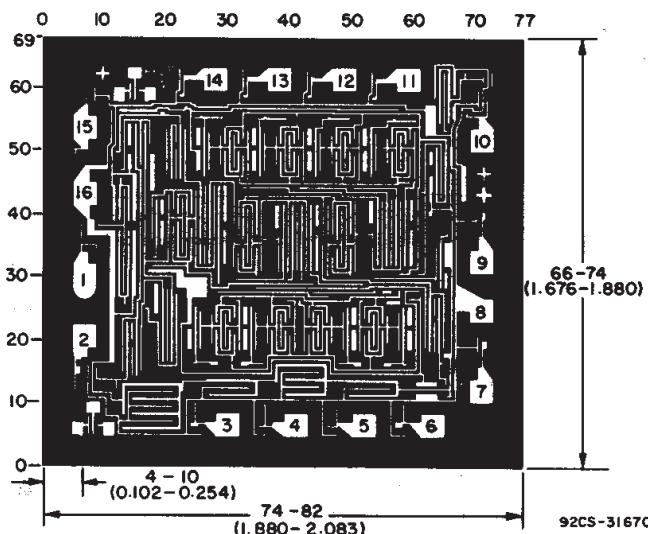


Fig. 21 – Waveforms for t_{PZL} , t_{PZH} ,
 t_{PLZ} , and t_{PHZ} (AND).



Dimensions and pad layout for CD4048BH.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated.
Grid graduations are in mils (10^{-3} inch).

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CD4048BE	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD4048BE
CD4048BE.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-55 to 125	CD4048BE
CD4048BF3A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	CD4048BF3A
CD4048BF3A.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	CD4048BF3A
CD4048BM	Obsolete	Production	SOIC (D) 16	-	-	Call TI	Call TI	-55 to 125	CD4048BM
CD4048BM96	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4048BM
CD4048BM96.A	Active	Production	SOIC (D) 16	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4048BM
CD4048BPW	Active	Production	TSSOP (PW) 16	90 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM048B
CD4048BPW.A	Active	Production	TSSOP (PW) 16	90 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM048B

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

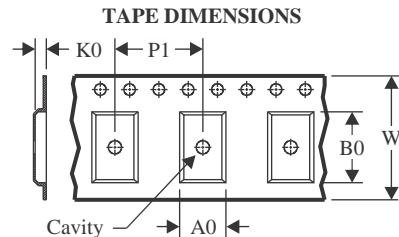
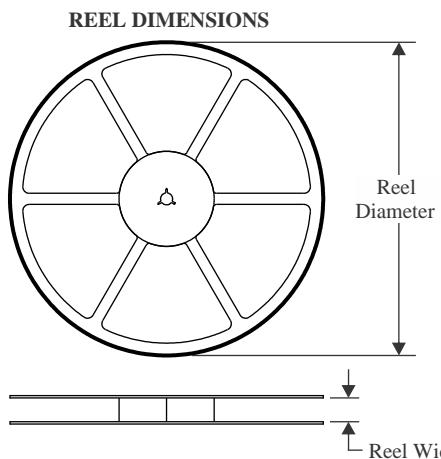
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF CD4048B, CD4048B-MIL :

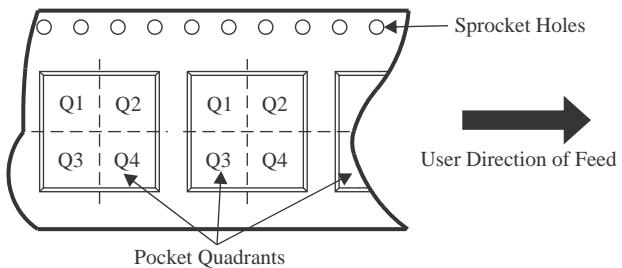
- Catalog : [CD4048B](#)
- Military : [CD4048B-MIL](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

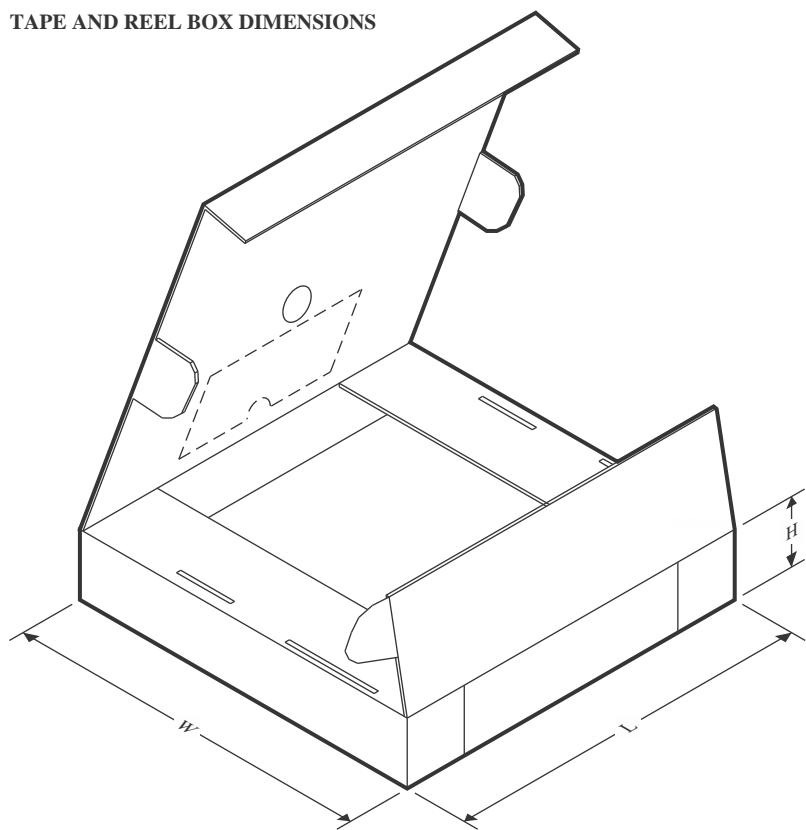
TAPE AND REEL INFORMATION

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

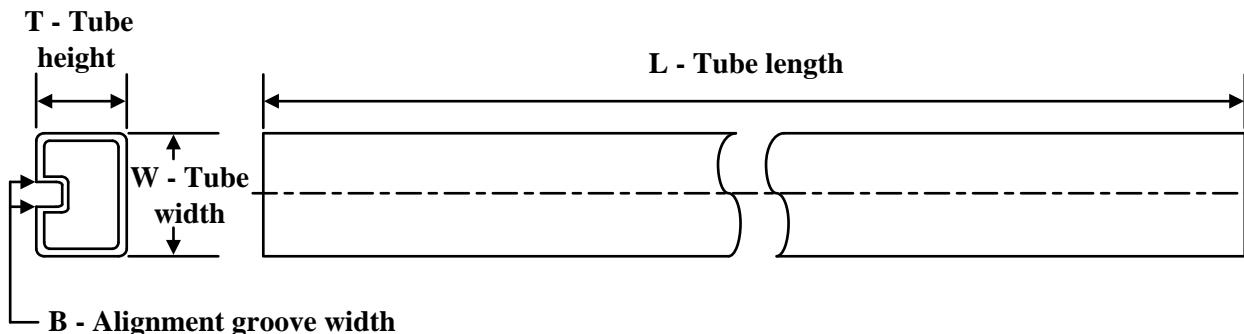
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4048BM96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4048BM96	SOIC	D	16	2500	340.5	336.1	32.0

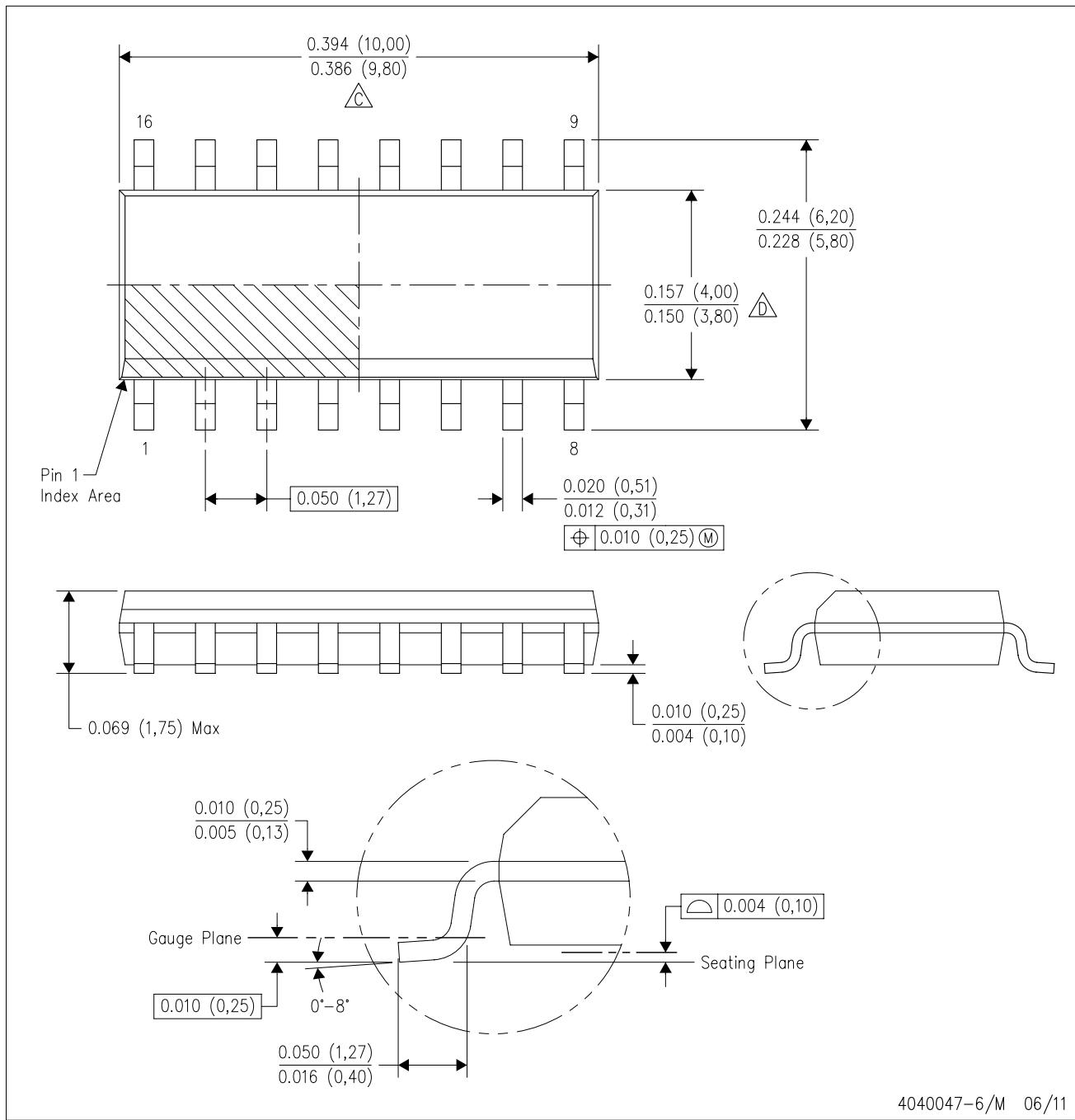
TUBE


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μ m)	B (mm)
CD4048BE	N	PDIP	16	25	506	13.97	11230	4.32
CD4048BE	N	PDIP	16	25	506	13.97	11230	4.32
CD4048BE.A	N	PDIP	16	25	506	13.97	11230	4.32
CD4048BE.A	N	PDIP	16	25	506	13.97	11230	4.32
CD4048BPW	PW	TSSOP	16	90	530	10.2	3600	3.5
CD4048BPW.A	PW	TSSOP	16	90	530	10.2	3600	3.5

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.

D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.

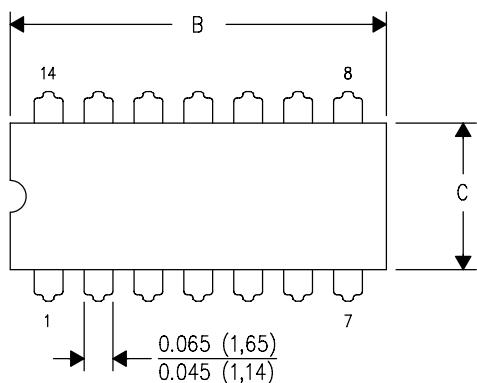
E. Reference JEDEC MS-012 variation AC.

4040047-6/M 06/11

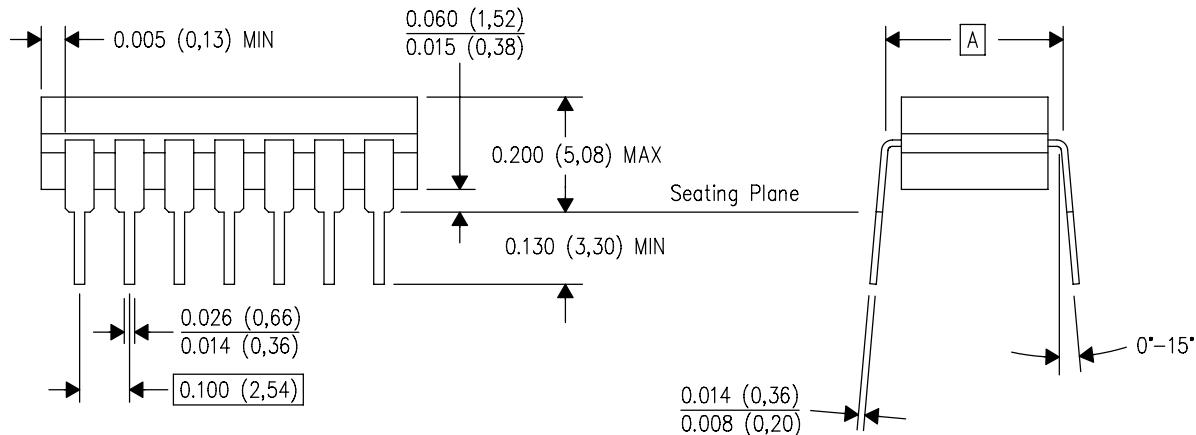
J (R-GDIP-T**)

14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



PINS **\nDIM	14	16	18	20
A	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC
B MAX	0.785 (19,94)	.840 (21,34)	0.960 (24,38)	1.060 (26,92)
B MIN	—	—	—	—
C MAX	0.300 (7,62)	0.300 (7,62)	0.310 (7,87)	0.300 (7,62)
C MIN	0.245 (6,22)	0.245 (6,22)	0.220 (5,59)	0.245 (6,22)



4040083/F 03/03

- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. This package is hermetically sealed with a ceramic lid using glass frit.
 - D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
 - E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

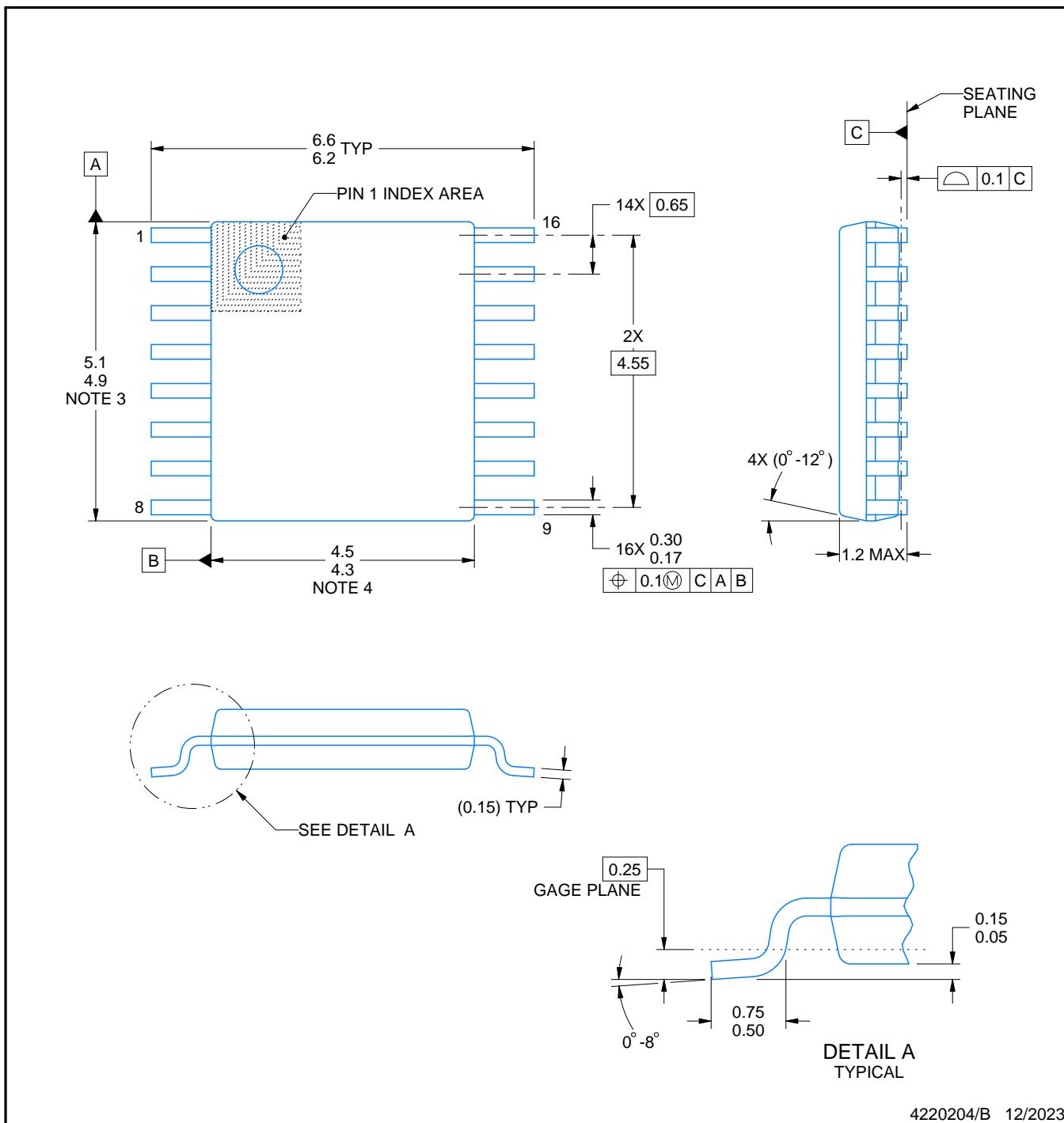
PACKAGE OUTLINE

PW0016A



TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

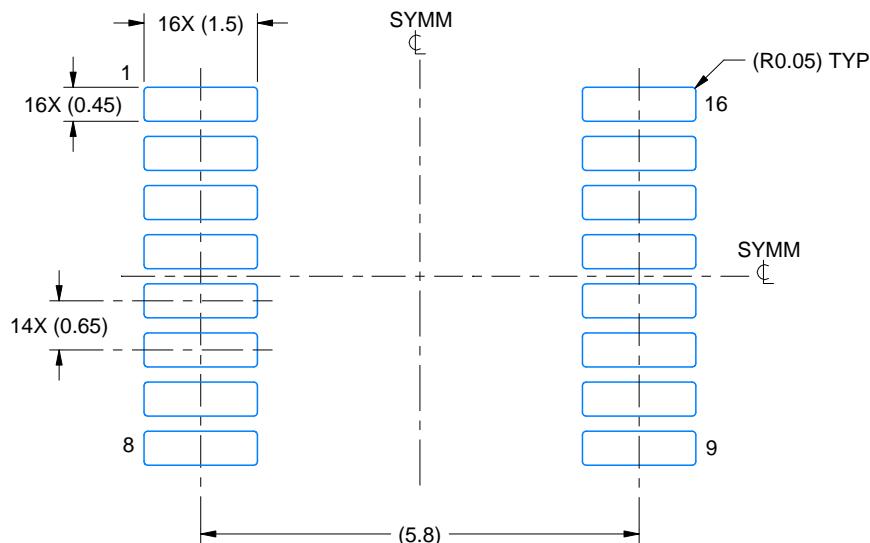
- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- This drawing is subject to change without notice.
- This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
- This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

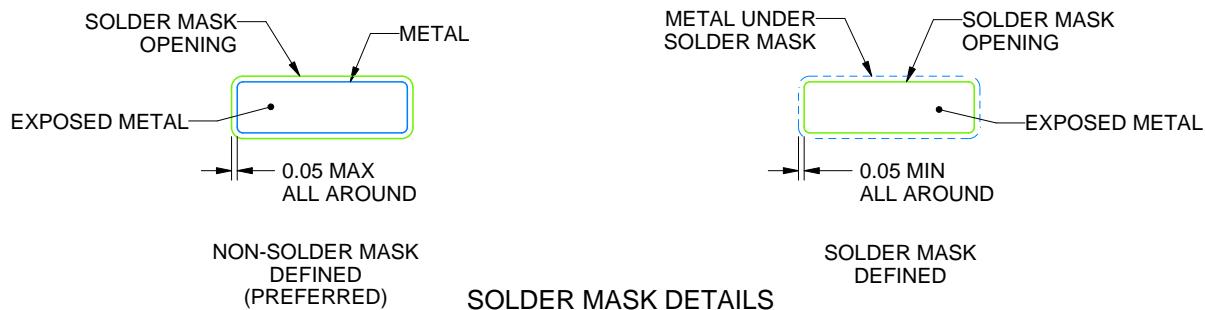
PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



4220204/B 12/2023

NOTES: (continued)

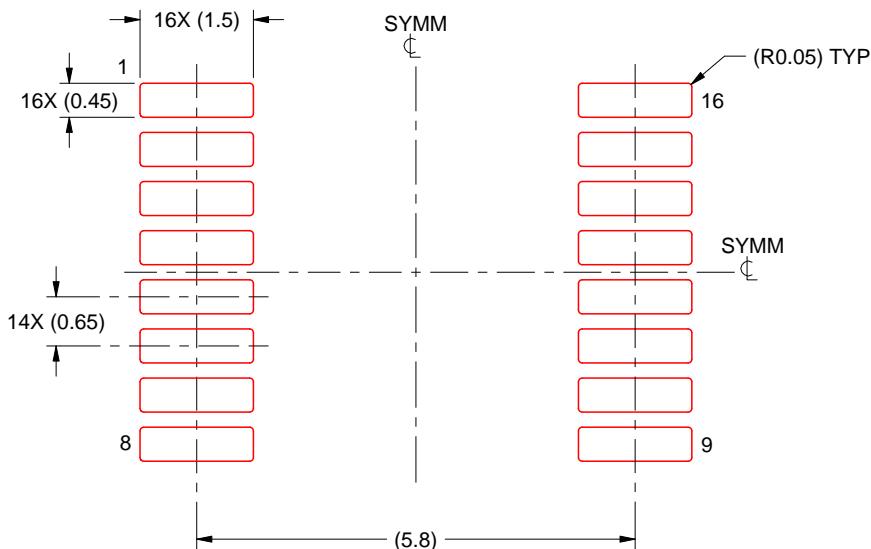
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/B 12/2023

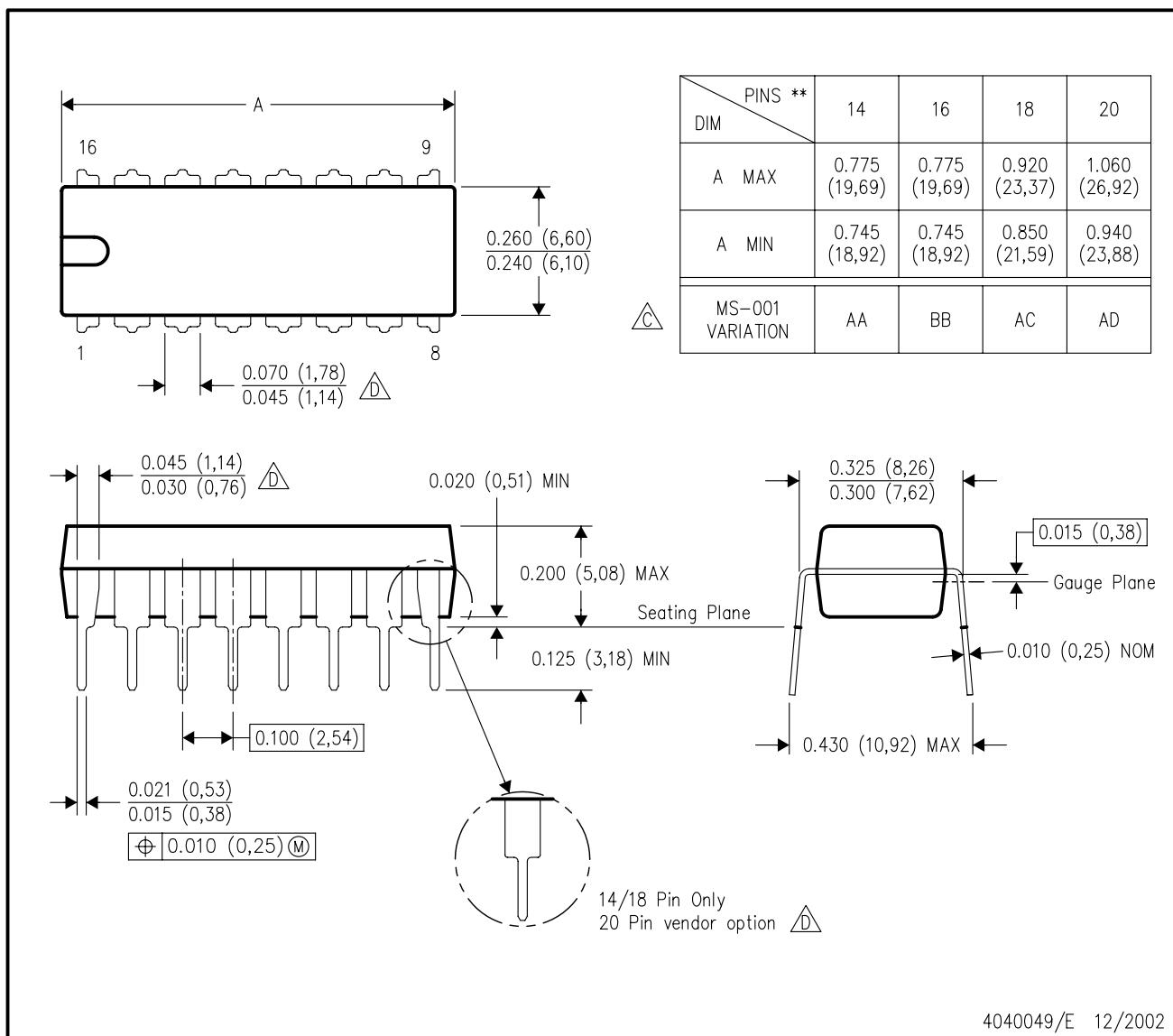
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



4040049/E 12/2002

NOTES: A. All linear dimensions are in inches (millimeters).
 B. This drawing is subject to change without notice.

Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).

The 20 pin end lead shoulder width is a vendor option, either half or full width.

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